

<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>				ATTY DOCKET NO. <b>YOR920030165US1</b>		APPLICATION NO. <b>10/671,938</b>	
				APPLICANT(S) <b>Chen, et al.</b>			
				FILING DATE <b>September 29, 2003</b>		GROUP ART UNIT <b>2161</b>	
<b>U.S. PATENT DOCUMENTS</b>							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		US-4,114,601	09/19/1978	Michael Allen Abels			
		US-5,190,059	03/02/1993	Carl E. Fabian, et al.			
		US-5,903,876	05/11/1999	Robert C. Hagemier			
		US-5,931,824	08/03/1999	William W. Stewart, et al.			
		US-5,953,707	09/14/1999	Ying Huang, et al.			
<b>U.S. PATENT APPLICATION PUBLICATIONS</b>							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		US-2002/0067263	06/06/2002	Benedict J. Tafoya, et al.			
		US-2002/0143320	10/03/2002	Bruce H. Levin			
		US-2003/0066537	04/10/2003	Carl E. Fabian, et al.			
		US-2003/0105394	06/05/2003	Carl R. Fabian, et al.			
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
<b>OTHER DOCUMENTS</b> <i>(Including Author, Title, Date, Pertinent Pages, Etc.)</i>							
		Japan sensor array can image full hemisphere without PC Help", April 15, 2002, AsiaPulseNews.					
		Paradigm and International Dispatch Center-IDC-to Co-Market Wireless Location Technology Solution, April 19, 2001, Business Wire, p2250. <i>(not available to Applicant; Examiner asked to consult internal file for 10/671,938)</i>					
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		US-5,961,572	10/05/1999	William N. Craport, et al.			
		US-6,003,016	12/14/1999	Robert C. Hagemier			
		US-6,076,007	06/13/2000	Mark England, et al.			
		US-6,078,899	06/20/2000	Paul A. Francisco, et al.			
		US-6,366,206	04/02/2002	Akira Ishikawa, et al.			

U.S. PATENT APPLICATION PUBLICATIONS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		US-2004/0084525	05/06/2004	Barrett Kreiner, et al.			
		US-2004/0129279	07/08/2004	Carl E. Fabian, et al.			
		US-2004/0201479	10/14/2004	Sharon R. Garber, et al.			
		US-2004/0250819	12/16/2004	William A. Blair, et al.			

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							YES	NO

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		US-6,400,272	06/04/2002	Henry N. Holtzman, et al.			
		US-6,424,262	07/23/2002	Sharon R. Garber, et al.			
		US-6,438,528	08/20/2002	Jan Sander Jensen, et al.			
		US-6,546,373	04/08/2003	Peter J. Cerra			
		US-6,600,418	07/29/2003	Robert C. Francis, et al.			

  

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		US-2007/0093709	04/26/2007	Dennis Lee Abernathie			
		US-2007/0290030	12/20/2007	Charles S. Fox, et al.			

  

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		US-6,640,214	10/28/2003	Narayan S. Nambudiri, et al.			
		US-6,669,089	12/30/2003	Eric R. Cybulski, et al.			
		US-6,768,419	07/27/2004	Sharon R. Garber, et al.			
		US-6,809,645	10/26/2004	Timothy E. Mason			
		US-6,861,954	03/01/2005	Bruce H. Levin			

  

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		US-6,900,731	05/31/2005	Barrett Kreiner, et al.			
		US-7,010,507	03/07/2006	William P. Anderson, et al.			
		US-7,019,650	03/28/2006	John P. Volpi, et al.			
		US-7,142,118	11/28/2006	John A. Hamilton, et al.			
		US-7,155,402	12/26/2006	Robert E. Dvorak			

  

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		<b>US-7,177,829</b>	<b>02/13/2007</b>	<b>Robert D. Wilson, et al.</b>			
		<b>US-7,307,530</b>	<b>12/11/2007</b>	<b>Carl E. Fabian, et al.</b>			
		<b>US-7,557,710</b>	<b>07/07/2009</b>	<b>Michael Sanchez, et al.</b>			
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